

### **FEATURES**

Latch-up immune under all circumstances 2.5 pF off source capacitance 12 pF off drain capacitance -0.6 pC charge injection Low leakage: 0.4 nA maximum at 85°C ±9 V to ±22 V dual-supply operation 9 V to 40 V single-supply operation 48 V supply maximum ratings Fully specified at ±15 V, ±20 V, +12 V, and +36 V Vss to VpD analog signal range

#### **APPLICATIONS**

High voltage signal routing Automatic test equipment Analog front-end circuits Precision data acquisition Industrial instrumentation Amplifier gain select Relay replacement

### **GENERAL DESCRIPTION**

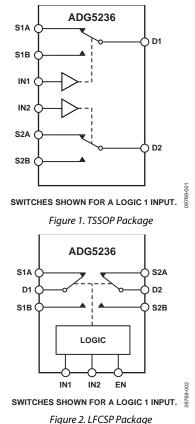
The ADG5236 is a monolithic CMOS device containing two independently selectable single-pole/double throw (SPDT) switches. An EN input on the LFCSP package enables or disables the device. When disabled, all channels switch off. Each switch conducts equally well in both directions when on and has an input signal range that extends to the supplies. In the off condition, signal levels up to the supplies are blocked. Both switches exhibit break-before-make switching action for use in multiplexer applications.

The ultralow capacitance and charge injection of these switches make them ideal solutions for data acquisition and sample-andhold applications, where low glitch and fast settling are required. Fast switching speed together with high signal bandwidth make the device suitable for video signal switching.

# High Voltage Latch-Up Proof, Dual SPDT Switches

# ADG5236

### FUNCTIONAL BLOCK DIAGRAMS



### **PRODUCT HIGHLIGHTS**

- Trench Isolation Guards Against Latch-Up. A dielectric trench separates the P and N channel transistors thereby preventing latch-up even under severe overvoltage conditions.
- 2. Ultralow Capacitance and <1 pC Charge Injection.
- Dual-Supply Operation.
  For applications where the analog signal is bipolar, the ADG5236 can be operated from dual supplies up to ±22 V.
- Single-Supply Operation. For applications where the analog signal is unipolar, the ADG5236 can be operated from a single rail power supply up to 40 V.
- 5. 3 V Logic-Compatible Digital Inputs.  $V_{INH} = 2.0 \text{ V}, V_{INL} = 0.8 \text{ V}.$
- 6. No V<sub>L</sub> Logic Power Supply Required.

#### Rev. B

#### Document Feedback

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### **REVISION HISTORY**

### 11/13—Rev. A to Rev. B

Changes to Features and Applications Sections Changes to Figure 23	
4/12—Rev. 0 to Rev. A	
Updated Outline Dimensions Changes to Ordering Guide	

7/11—Revision 0: Initial Version

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### **SPECIFICATIONS**

### ±15 V DUAL SUPPLY

 $V_{\text{DD}}$  = +15 V  $\pm$  10%,  $V_{\text{SS}}$  = –15 V  $\pm$  10%, GND = 0 V, unless otherwise noted.

### Table 1. Parameter

Parameter	25°C	-40°C to +85°C	-40°C to +125°C	Unit	<b>Test Conditions/Comments</b>
ANALOG SWITCH					
Analog Signal Range			V <sub>DD</sub> to V <sub>SS</sub>	V max	
On Resistance, R <sub>ON</sub>	160			Ωtyp	$V_s = \pm 10 \text{ V}, \text{ I}_s = -1 \text{ mA}, \text{ see Figure 25}$
	200	250	280	Ωmax	$V_{DD} = +13.5 V, V_{SS} = -13.5 V$
On-Resistance Match Between Channels, ΔR <sub>ON</sub>	1.4			Ωtyp	$V_{s} = \pm 10 \text{ V}, I_{s} = -1 \text{ mA}$
	8	9	10	Ωmax	
On-Resistance Flatness, R <sub>FLAT (ON)</sub>	38			Ωtyp	$V_{s} = \pm 10 V$ , $I_{s} = -1 mA$
	50	65	70	Ωmax	
LEAKAGE CURRENTS					$V_{DD} = +16.5 \text{ V}, V_{SS} = -16.5 \text{ V}$
Source Off Leakage, I <sub>s</sub> (Off)	0.01			nA typ	$V_s = \pm 10 \text{ V}, V_D = \mp 10 \text{ V}, \text{ see Figure 27}$
	0.1	0.2	0.4	nA max	
Drain Off Leakage, I <sub>D</sub> (Off)	0.01			nA typ	$V_{s} = \pm 10 \text{ V}, V_{D} = \mp 10 \text{ V}, \text{ see Figure 27}$
	0.1	0.4	1.2	nA max	
Channel On Leakage, I <sub>D</sub> (On), I <sub>S</sub> (On)	0.02			nA typ	$V_{s} = V_{D} = \pm 10 V$ , see Figure 24
	0.2	0.4	1.2	nA max	
DIGITAL INPUTS					
Input High Voltage, V <sub>INH</sub>			2.0	V min	
Input Low Voltage, V <sub>INL</sub>			0.8	V max	
Input Current, l <sub>INL</sub> or l <sub>INH</sub>	0.002		0.0	μA typ	$V_{IN} = V_{GND} \text{ or } V_{DD}$
	0.002		±0.1	µA max	
Digital Input Capacitance, C <sub>IN</sub>	3			pF typ	
DYNAMIC CHARACTERISTICS <sup>1</sup>	-			F- 7F	
	150			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
· · · · · · · · · · · · · · · · · · ·	230	280	315	ns max	$V_s = 10 V$ , see Figure 30
ton	170			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
	215	265	300	ns max	$V_s = 10 V$ , see Figure 32
toff	160			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
	185	205	225	ns max	$V_s = 10 V$ , see Figure 32
Break-Before-Make Time Delay, t₀	75			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
			30	ns min	$V_{s1} = V_{s2} = 10 V$ , see Figure 31
Charge Injection, Q <sub>INJ</sub>	-0.6			pC typ	$V_s = 0 V$ , $R_s = 0 \Omega$ , $C_L = 1 nF$ , see Figure 33
Off Isolation	-85			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 28
Channel-to-Channel Crosstalk	-85			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 26
–3 dB Bandwidth	266			MHz typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , see Figure 29
Insertion Loss	-7			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 29
Cs (Off)	2.5			pF typ	$V_{s} = 0 V, f = 1 MHz$
$C_{D}$ (Off)	12			pF typ	$V_{s} = 0 V, f = 1 MHz$
C <sub>D</sub> (On), C <sub>s</sub> (On)	15			pF typ	$V_{s} = 0 V, f = 1 MHz$

Parameter	25°C	-40°C to +85°C	-40°C to +125°C	Unit	Test Conditions/Comments
POWER REQUIREMENTS					$V_{DD} = +16.5 V$ , $V_{SS} = -16.5 V$
I <sub>DD</sub>	45			μA typ	Digital inputs = $0 V$ or $V_{DD}$
	55		70	μA max	
lss	0.001			μA typ	Digital inputs = $0 V \text{ or } V_{DD}$
			1	μA max	
V <sub>DD</sub> /V <sub>SS</sub>			±9/±22	V min/V max	GND = 0V

<sup>1</sup> Guaranteed by design; not subject to production test.

### ±20 V DUAL SUPPLY

 $V_{\text{DD}}$  = +20 V  $\pm$  10%,  $V_{\text{SS}}$  = -20 V  $\pm$  10%, GND = 0 V, unless otherwise noted.

### Table 2.

Parameter	25°C	-40°C to +85°C	-40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			$V_{\text{DD}}$ to $V_{\text{SS}}$	V max	
On Resistance, Ron	140			Ωtyp	$V_s = \pm 15 V$ , $I_s = -1 mA$ , see Figure 25
	160	200	230	Ωmax	$V_{DD} = +18 V, V_{SS} = -18 V$
On-Resistance Match	1.3			Ωtyp	$V_{s} = \pm 15 V, I_{s} = -1 mA$
Between Channels, ΔRon					
	8	9	10	Ωmax	
On-Resistance Flatness, R <sub>FLAT (ON)</sub>	33			Ωtyp	$V_s = \pm 15 V$ , $I_s = -1 mA$
	45	55	60	Ωmax	
LEAKAGE CURRENTS					$V_{DD} = +22 V, V_{SS} = -22 V$
Source Off Leakage, Is (Off)	0.01			nA typ	$V_s = \pm 15 V$ , $V_D = \mp 15 V$ , see Figure 27
	0.1	0.2	0.4	nA max	
Drain Off Leakage, I <sub>D</sub> (Off)	0.01			nA typ	$V_s = \pm 15 \text{ V}, V_D = \mp 15 \text{ V}, \text{ see Figure } 27$
	0.1	0.4	1.2	nA max	
Channel On Leakage, I <sub>D</sub> (On), I <sub>s</sub> (On)	0.02			nA typ	$V_s = V_D = \pm 15 V$ , see Figure 24
	0.2	0.4	1.2	nA max	
DIGITAL INPUTS					
Input High Voltage, V <sub>INH</sub>			2.0	V min	
Input Low Voltage, VINL			0.8	V max	
Input Current, IINL or IINH	0.002			μA typ	$V_{IN} = V_{GND} \text{ or } V_{DD}$
			±0.1	µA max	
Digital Input Capacitance, C <sub>IN</sub>	3			pF typ	
DYNAMIC CHARACTERISTICS <sup>1</sup>					
Transition Time, t <sub>TRANSITION</sub>	150			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
	210	260	290	ns max	$V_s = 10 V$ , see Figure 30
t <sub>on</sub>	150			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
	190	235	267	ns max	$V_s = 10 V$ , see Figure 32
t <sub>OFF</sub>	155			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
	180	200	215	ns max	$V_s = 10 V$ , see Figure 32
Break-Before-Make Time Delay, t <sub>D</sub>	60			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
			30	ns min	$V_{s1} = V_{s2} = 10 V$ , see Figure 31
Charge Injection, Q <sub>INJ</sub>	-0.6			pC typ	$V_s = 0 V$ , $R_s = 0 \Omega$ , $C_L = 1 nF$ , see Figure 33
Off Isolation	-85			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ ,
	0.5			dD to a	see Figure 28
Channel-to-Channel Crosstalk	-85			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 26
–3 dB Bandwidth	266			MHz typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , see Figure 29
Insertion Loss	-7			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 29

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Parameter	25°C	-40°C to +85°C	-40°C to +125°C	Unit	<b>Test Conditions/Comments</b>
Cs (Off)	2.5			pF typ	$V_{s} = 0 V, f = 1 MHz$
C <sub>D</sub> (Off)	12			pF typ	$V_{s} = 0 V, f = 1 MHz$
C <sub>D</sub> (On), C <sub>s</sub> (On)	15			pF typ	$V_{s} = 0 V, f = 1 MHz$
POWER REQUIREMENTS					$V_{DD} = +22 V, V_{SS} = -22 V$
ldd	50			μA typ	Digital inputs = $0 V$ or $V_{DD}$
	70		110	μA max	
Iss	0.001			μA typ	Digital inputs = $0 V$ or $V_{DD}$
			1	μA max	
V <sub>DD</sub> /V <sub>SS</sub>			±9/±22	V min/V max	GND = 0V

<sup>1</sup> Guaranteed by design; not subject to production test.

### **12 V SINGLE SUPPLY**

 $V_{\text{DD}}$  = 12 V  $\pm$  10%,  $V_{\text{SS}}$  = 0 V, GND = 0 V, unless otherwise noted.

### Table 3.

Parameter	25°C	-40°C to +85°C	-40°C to +125°C	Unit	<b>Test Conditions/Comments</b>
ANALOG SWITCH					
Analog Signal Range			$0 V$ to $V_{\text{DD}}$	V max	
On Resistance, R <sub>ON</sub>	350			Ωtyp	$V_s = 0 V$ to 10 V, $I_s = -1 mA$ , see Figure 25
	500	610	700	Ωmax	$V_{DD} = 10.8 V, V_{SS} = 0 V$
On-Resistance Match Between Channels, ΔR <sub>ON</sub>	3			Ωtyp	$V_{\text{S}}=0V\text{to}10V\text{, }I_{\text{S}}=-1\text{mA}$
	20	21	22	Ωmax	
On-Resistance Flatness, R <sub>FLAT (ON)</sub>	145			Ωtyp	$V_s = 0 V$ to 10 V, $I_s = -1 mA$
	280	335	370	Ωmax	
LEAKAGE CURRENTS					$V_{DD} = 13.2 V, V_{SS} = 0 V$
Source Off Leakage, $I_s$ (Off)	0.01			nA typ	$V_s = 1 \text{ V}/10 \text{ V}, V_D = 10 \text{ V}/1 \text{ V},$ see Figure 27
	0.1	0.2	0.4	nA max	
Drain Off Leakage, $I_D$ (Off)	0.01			nA typ	$V_s = 1 \text{ V}/10 \text{ V}, V_D = 10 \text{ V}/1 \text{ V},$ see Figure 27
	0.1	0.4	1.2	nA max	
Channel On Leakage, I <sub>D</sub> (On), I <sub>S</sub> (On)	0.02			nA typ	$V_S = V_D = 1 \text{ V}/10 \text{ V}$ , see Figure 24
	0.2	0.4	1.2	nA max	
DIGITAL INPUTS					
Input High Voltage, V <sub>INH</sub>			2.0	V min	
Input Low Voltage, VINL			0.8	V max	
Input Current, I <sub>INL</sub> or I <sub>INH</sub>	0.002			μA typ	$V_{IN} = V_{GND} \text{ or } V_{DD}$
			±0.1	μA max	
Digital Input Capacitance, C <sub>IN</sub>	3			pF typ	
DYNAMIC CHARACTERISTICS <sup>1</sup>					
Transition Time, transition	220			ns typ	$R_L = 300 \Omega$ , $C_L = 35 pF$
	390	430	490	ns max	$V_s = 8 V$ , see Figure 30
ton	275			ns typ	$R_L = 300 \Omega$ , $C_L = 35 pF$
	380	440	510	ns max	$V_s = 8 V$ , see Figure 32
toff	160			ns typ	$R_L = 300 \Omega$ , $C_L = 35 pF$
	195	225	245	ns max	$V_s = 8 V$ , see Figure 32
Break-Before-Make Time Delay, $t_{\text{D}}$	145			ns typ	$R_L = 300 \Omega$ , $C_L = 35 pF$
			65	ns min	$V_{S1} = V_{S2} = 8 V$ , see Figure 31
Charge Injection, $Q_{INJ}$	-0.6			pC typ	$V_s = 6 V$ , $R_s = 0 \Omega$ , $C_L = 1 nF$ , see Figure 33

Parameter	25°C	-40°C to +85°C	-40°C to +125°C	Unit	Test Conditions/Comments
Off Isolation	-90			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 28
Channel-to-Channel Crosstalk	-90			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 26
–3 dB Bandwidth	185			MHz typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , see Figure 29
Insertion Loss	-11			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 29
Cs (Off)	3			pF typ	$V_{s} = 6 V, f = 1 MHz$
C <sub>D</sub> (Off)	16			pF typ	$V_{s} = 6 V, f = 1 MHz$
C <sub>D</sub> (On), C <sub>s</sub> (On)	16			pF typ	$V_{s} = 6 V, f = 1 MHz$
POWER REQUIREMENTS					$V_{DD} = 13.2 V$
l <sub>DD</sub>	40			μA typ	Digital inputs = $0 V \text{ or } V_{DD}$
			65	μA max	
V <sub>DD</sub>			9/40	V min/V max	$GND = 0 V, V_{SS} = 0 V$

<sup>1</sup> Guaranteed by design; not subject to production test.

### **36 V SINGLE SUPPLY**

 $V_{\text{DD}}$  = 36 V  $\pm$  10%,  $V_{\text{SS}}$  = 0 V, GND = 0 V, unless otherwise noted.

#### Table 4.

Parameter	25°C	-40°C to +85°C	-40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			$0 V to V_{DD}$	V max	
On Resistance, R <sub>ON</sub>	150			Ωtyp	$V_s = 0 V$ to 30 V, $I_s = -1 mA$ , see Figure 25
	170	215	245	Ωmax	$V_{DD} = 32.4 V, V_{SS} = 0 V$
On-Resistance Match Between Channels, ΔR <sub>on</sub>	1.4			Ωtyp	$V_{\text{S}}=0V\text{ to }30V\text{, }I_{\text{S}}=-1\text{mA}$
	8	9	10	Ωmax	
On-Resistance Flatness, R <sub>FLAT(ON)</sub>	35			Ωtyp	$V_{s} = 0 V$ to 30 V, $I_{s} = -1 mA$
	50	60	65	Ωmax	
LEAKAGE CURRENTS					$V_{DD} = 39.6 V, V_{SS} = 0 V$
Source Off Leakage, $I_S$ (Off)	0.01			nA typ	$V_s = 1 \text{ V}/30 \text{ V}, V_D = 30 \text{ V}/1 \text{ V},$ see Figure 27
	0.1	0.2	0.4	nA max	
Drain Off Leakage, $I_D$ (Off)	0.01			nA typ	$V_s = 1 \text{ V}/30 \text{ V}, V_D = 30 \text{ V}/1 \text{ V},$ see Figure 27
	0.1	0.4	1.2	nA max	
Channel On Leakage, $I_D$ (On), $I_S$ (On)	0.02			nA typ	$V_{\text{S}} = V_{\text{D}} = 1 \text{ V}/30 \text{ V}$ , see Figure 24
	0.2	0.4	1.2	nA max	
DIGITAL INPUTS					
Input High Voltage, V <sub>INH</sub>			2.0	V min	
Input Low Voltage, V <sub>INL</sub>			0.8	V max	
Input Current, IINL or IINH	0.002			μA typ	$V_{IN} = V_{GND} \text{ or } V_{DD}$
			±0.1	µA max	
Digital Input Capacitance, C <sub>IN</sub>	3			pF typ	
DYNAMIC CHARACTERISTICS <sup>1</sup>					
Transition Time, t <sub>TRANSITION</sub>	180			ns typ	$R_L = 300 \Omega$ , $C_L = 35 pF$
	250	275	305	ns max	Vs = 18 V, see Figure 30
t <sub>on</sub>	170			ns typ	$R_L = 300 \ \Omega, C_L = 35 \ pF$
	225	265	295	ns max	$V_s = 18 V$ , see Figure 32

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Parameter	25°C	-40°C to +85°C	-40°C to +125°C	Unit	<b>Test Conditions/Comments</b>
toff	170			ns typ	$R_L = 300 \Omega$ , $C_L = 35 pF$
	215	215	225	ns max	Vs = 18 V, see Figure 32
Break-Before-Make Time Delay, t <sub>D</sub>	75			ns typ	$R_L = 300 \Omega$ , $C_L = 35 pF$
			35	ns min	$V_{S1} = V_{S2} = 18 V$ , see Figure 31
Charge Injection, Q <sub>INJ</sub>	-0.6			pC typ	$V_s = 18 \text{ V}, \text{ R}_s = 0 \Omega, \text{ C}_L = 1 \text{ nF},$ see Figure 33
Off Isolation	-85			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 28
Channel-to-Channel Crosstalk	-85			dB typ	R∟ = 50 Ω, C∟ = 5 pF, f = 1 MHz, see Figure 26
–3 dB Bandwidth	266			MHz typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , see Figure 29
Insertion Loss	-7			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 29
Cs (Off)	2.5			pF typ	$V_{s} = 18 V, f = 1 MHz$
C <sub>D</sub> (Off)	12			pF typ	$V_{s} = 18 V, f = 1 MHz$
C <sub>D</sub> (On), C <sub>s</sub> (On)	15			pF typ	$V_{s} = 18 V, f = 1 MHz$
POWER REQUIREMENTS					$V_{DD} = 39.6 V$
I <sub>DD</sub>	85			μA typ	Digital inputs = $0 V \text{ or } V_{DD}$
	100		130	μA max	
V <sub>DD</sub>			9/40	V min/V max	$GND = 0 V, V_{SS} = 0 V$

<sup>1</sup> Guaranteed by design; not subject to production test.

### CONTINUOUS CURRENT PER CHANNEL, SxA, SxB, OR Dx

### Table 5.

Parameter	25°C	85°C	125°C	Unit	
CONTINUOUS CURRENT, SxA, SxB, or Dx					
$V_{DD} = +15 V, V_{SS} = -15 V$					
TSSOP ( $\theta_{JA} = 112.6^{\circ}C/W$ )	19	7	2.8	mA max	
LFCSP ( $\theta_{JA} = 30.4^{\circ}C/W$ )	30	7.7	2.8	mA max	
$V_{DD} = +20 \text{ V}, \text{ V}_{SS} = -20 \text{ V}$					
TSSOP ( $\theta_{JA} = 112.6^{\circ}C/W$ )	21	7	2.8	mA max	
LFCSP ( $\theta_{JA} = 30.4^{\circ}C/W$ )	31	7.7	2.8	mA max	
$V_{DD} = 12 V, V_{SS} = 0 V$					
TSSOP ( $\theta_{JA} = 112.6^{\circ}C/W$ )	14	6.3	2.7	mA max	
LFCSP ( $\theta_{JA} = 30.4^{\circ}C/W$ )	22.5	7.3	2.8	mA max	
$V_{DD} = 36 V, V_{SS} = 0 V$					
TSSOP ( $\theta_{JA} = 112.6^{\circ}C/W$ )	24	7.4	2.8	mA max	
LFCSP ( $\theta_{JA} = 30.4^{\circ}C/W$ )	35	7.8	2.8	mA max	

### **ABSOLUTE MAXIMUM RATINGS**

 $T_A = 25^{\circ}C$ , unless otherwise noted.

#### Table 6.

Parameter	Rating	
V <sub>DD</sub> to V <sub>SS</sub>	48 V	
V <sub>DD</sub> to GND	–0.3 V to +48 V	
Vss to GND	+0.3 V to -48 V	
Analog Inputs <sup>1</sup>	V <sub>ss</sub> – 0.3 V to V <sub>DD</sub> + 0.3 V or 30 mA, whichever occurs first	
Digital Inputs <sup>1</sup>	V <sub>ss</sub> – 0.3 V to V <sub>DD</sub> + 0.3 V or 30 mA, whichever occurs first	
Peak Current, SxA, SxB, or Dx Pin	63 mA (pulsed at 1 ms, 10% duty cycle maximum)	
Continuous Current, SxA, SxB, or Dx <sup>2</sup>	Data + 15%	
Temperature Range		
Operating	–40°C to +125°C	
Storage	–65°C to +150°C	
Junction Temperature	150°C	
Thermal Impedance, θ <sub>JA</sub>		
16-Lead TSSOP (4-Layer Board)	112°C/W	
16-Lead LFCSP	30.4°C/W	
Reflow Soldering Peak Temperature, Pb Free	260(+0/-5)°C	

<sup>1</sup> Overvoltages at the INx, SxA, SxB, and Dx pins are clamped by internal diodes. Limit the current to the maximum ratings given.

<sup>2</sup> See Table 5.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Only one absolute maximum rating can be applied at any one time.

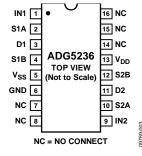
### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

### **PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS**

9769-



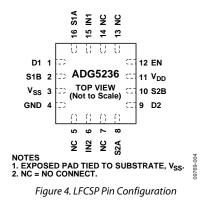


Figure 3. TSSOP Pin Configuration

#### **Table 7. Pin Function Descriptions**

Pin No.				
TSSOP	LFCSP	Mnemonic	Description	
1	15	IN1	Logic Control Input 1.	
2	16	S1A	Source Terminal 1A. This pin can be an input or output.	
3	1	D1	Drain Terminal 1. This pin can be an input or output.	
4	2	S1B	Source Terminal 1B. This pin can be an input or output.	
5	3	Vss	Most Negative Power Supply Potential.	
6	4	GND	Ground (0 V) Reference.	
7, 8, 14 to 16	5, 7, 13, 14	NC	No Connect. These pins are open.	
9	6	IN2	Logic Control Input 2.	
10	8	S2A	Source Terminal 2A. This pin can be an input or output.	
11	9	D2	Drain Terminal 2. This pin can be an input or output.	
12	10	S2B	Source Terminal 2B. This pin can be an input or output.	
13	11	V <sub>DD</sub>	Most Positive Power Supply Potential.	
N/A <sup>1</sup>	12	EN	Active High Digital Input. When this pin is low, the device is disabled and all switches are off. When this pin is high, the INx logic inputs determine the on switches.	
N/A <sup>1</sup>	EP	Exposed Pad	Exposed Pad. The exposed pad is connected internally. For increased reliability of the solder joints and maximum thermal capability, it is recommended that the pad be soldered to the substrate, V <sub>ss</sub> .	

<sup>1</sup> N/A means not applicable.

### **TRUTH TABLES FOR SWITCHES**

#### **Table 8. TSSOP Truth Table**

INx	SxA	SxB
0	Off	On
1	On	Off

#### Table 9. LFCSP Truth Table

EN	INx	SxA	SxB
0	X <sup>1</sup>	Off	Off
1	0	Off	On
1	1	On	Off

<sup>1</sup> X means don't care.

### **TYPICAL PERFORMANCE CHARACTERISTICS**

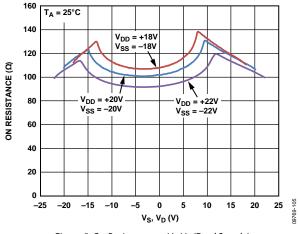
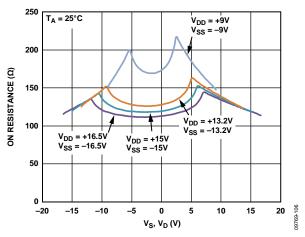
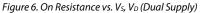


Figure 5. On Resistance vs. V<sub>5</sub>, V<sub>D</sub> (Dual Supply)





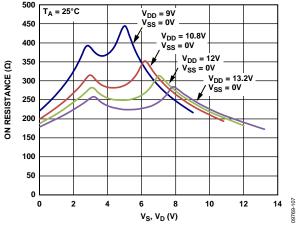


Figure 7. On Resistance vs. Vs, VD (Single Supply)

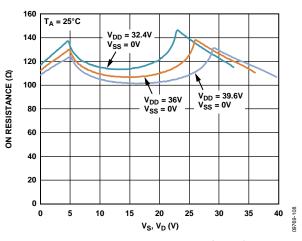


Figure 8. On Resistance vs. V<sub>s</sub>, V<sub>D</sub> (Single Supply)

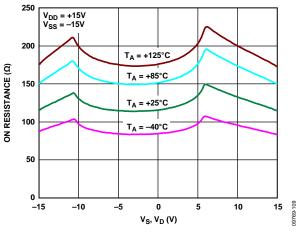


Figure 9. On Resistance vs.  $V_D$  or  $V_S$  for Different Temperatures, ±15 V Dual Supply

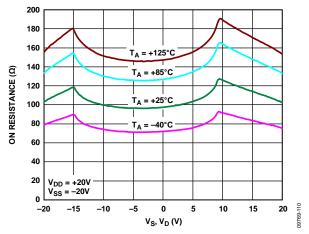


Figure 10. On Resistance vs.  $V_D$  or  $V_S$  for Different Temperatures,  $\pm 20$  V Dual Supply

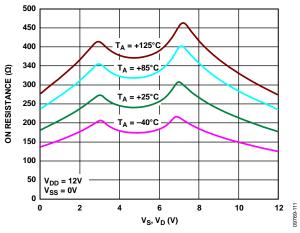


Figure 11. On Resistance vs.  $V_D$  or  $V_S$  for Different Temperatures, 12 V Single Supply

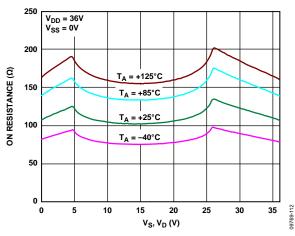


Figure 12. On Resistance vs.  $V_5$  or  $V_D$  for Different Temperatures, 36 V Single Supply

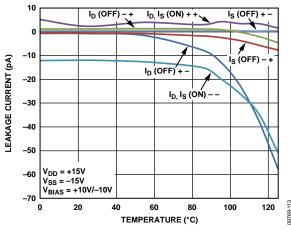


Figure 13. Leakage Current vs. Temperature,  $\pm 15$  V Dual Supply

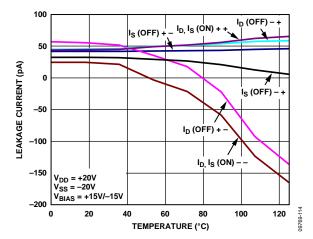
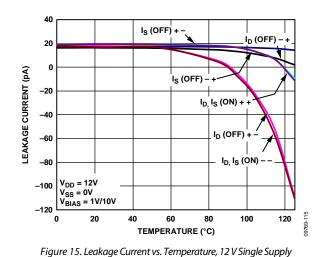


Figure 14. Leakage Current vs. Temperature,  $\pm 20$  V Single Supply



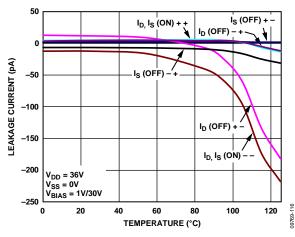
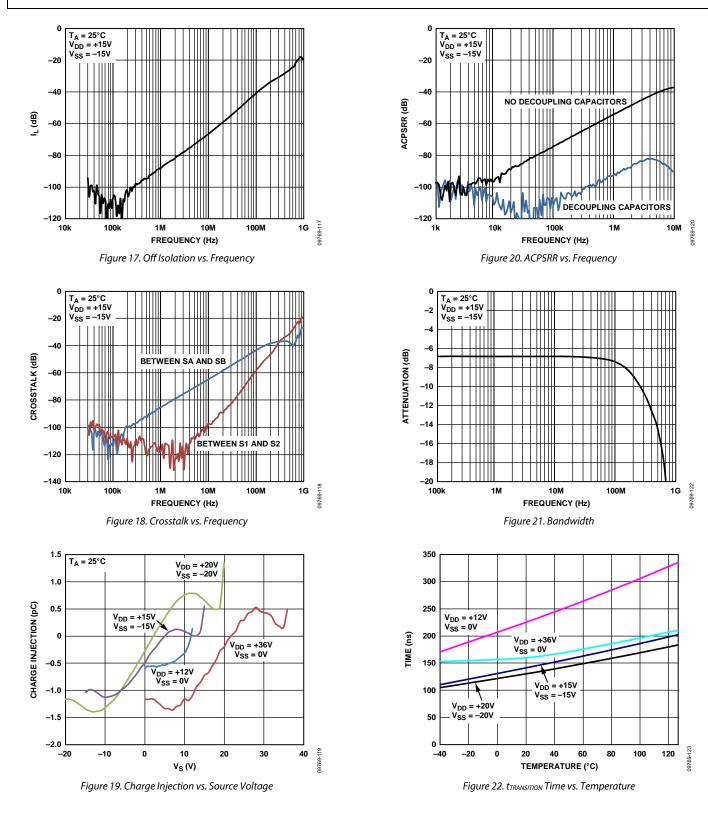


Figure 16. Leakage Current vs. Temperature, 36 V Single Supply

## ADG5236



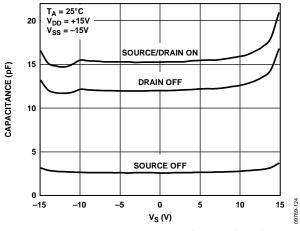
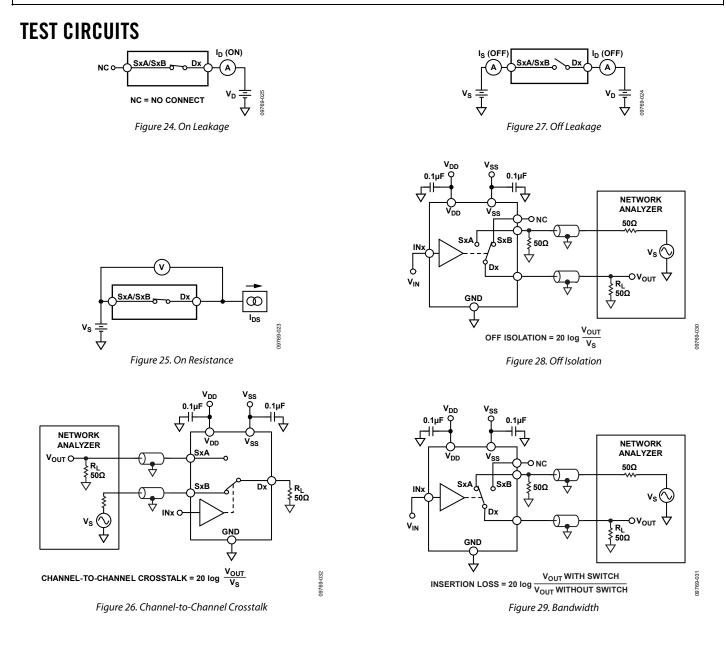


Figure 23. Capacitance vs. Source Voltage, Dual Supply



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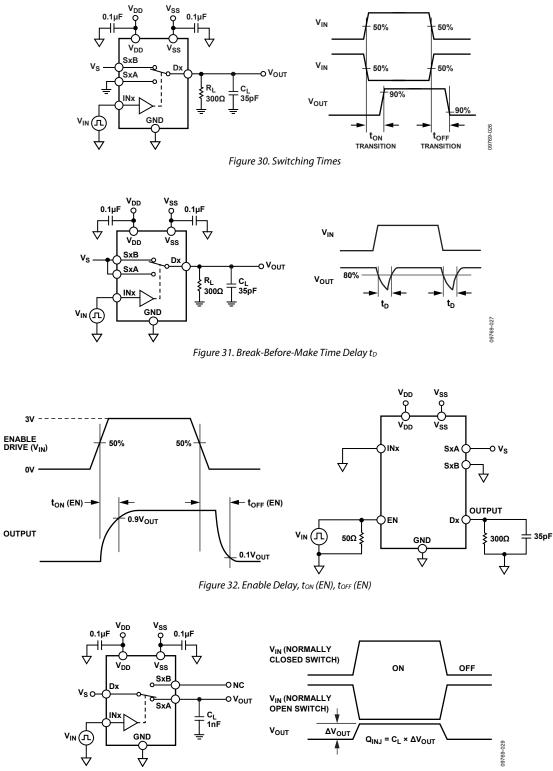


Figure 33. Charge Injection

### TERMINOLOGY

#### $\mathbf{I}_{DD}$

 $I_{\rm DD}$  represents the positive supply current.

### Iss

Iss represents the negative supply current.

### VD, Vs

 $V_{\rm D}$  and  $V_{\rm S}$  represent the analog voltage on Terminal D and Terminal S, respectively.

### Ron

 $R_{\mbox{\scriptsize ON}}$  represents the ohmic resistance between Terminal D and Terminal S.

### $\Delta R_{ON}$

 $\Delta R_{\rm ON}$  represents the difference between the  $R_{\rm ON}$  of any two channels.

### R<sub>FLAT (ON)</sub>

Flatness that is defined as the difference between the maximum and minimum value of on resistance measured over the specified analog signal range is represented by  $R_{FLAT (ON)}$ .

### Is (Off)

 $I_{\text{S}}\left(\text{Off}\right)$  is the source leakage current with the switch off.

### I<sub>D</sub> (Off)

 $I_{\rm D}\left(Off\right)$  is the drain leakage current with the switch off.

### $I_{D}$ (On), $I_{S}$ (On)

 $I_{\rm D}$  (On) and  $I_{\rm S}$  (On) represent the channel leakage currents with the switch on.

### VINL

 $V_{\mbox{\scriptsize INL}}$  is the maximum input voltage for Logic 0.

### VINH

 $V_{INH}$  is the minimum input voltage for Logic 1.

### $I_{\rm INL}, I_{\rm INH}$

 $I_{\rm INL}$  and  $I_{\rm INH}$  represent the low and high input currents of the digital inputs.

### C<sub>D</sub> (Off)

 $C_D$  (Off) represents the off switch drain capacitance, which is measured with reference to ground.

### Cs (Off)

C<sub>s</sub> (Off) represents the off switch source capacitance, which is measured with reference to ground.

### $C_D$ (On), $C_s$ (On)

 $C_D$  (On) and  $C_S$  (On) represent on switch capacitances, which are measured with reference to ground.

C<sub>IN</sub> is the digital input capacitance.

#### ton

 $t_{\rm ON}$  represents the delay between applying the digital control input and the output switching on.

#### toff

 $t_{\mbox{\scriptsize OFF}}$  represents the delay between applying the digital control input and the output switching off.

#### t<sub>D</sub>

 $t_{\rm D}$  represents the off time measured between the 80% point of both switches when switching from one address state to another.

#### **Off Isolation**

Off isolation is a measure of unwanted signal coupling through an off switch.

#### **Charge Injection**

Charge injection is a measure of the glitch impulse transferred from the digital input to the analog output during switching.

#### Crosstalk

Crosstalk is a measure of unwanted signal that is coupled through from one channel to another as a result of parasitic capacitance.

### Bandwidth

Bandwidth is the frequency at which the output is attenuated by 3 dB.

### On Response

On response is the frequency response of the on switch.

#### **Insertion Loss**

Insertion loss is the loss due to the on resistance of the switch.

### AC Power Supply Rejection Ratio (ACPSRR)

ACPSRR is the ratio of the amplitude of signal on the output to the amplitude of the modulation. This is a measure of the ability of the device to avoid coupling noise and spurious signals that appear on the supply voltage pin to the output of the switch. The dc voltage on the device is modulated by a sine wave of 0.62 V p-p.

### **TRENCH ISOLATION**

In the ADG5236, an insulating oxide layer (trench) is placed between the NMOS and the PMOS transistors of each CMOS switch. Parasitic junctions, which occur between the transistors in junction isolated switches, are eliminated, and the result is a completely latch-up proof switch.

In junction isolation, the N and P wells of the PMOS and NMOS transistors form a diode that is reverse-biased under normal operation. However, during overvoltage conditions, this diode can become forward-biased. A silicon controlled rectifier (SCR) type circuit is formed by the two transistors causing a significant amplification of the current that, in turn, leads to latch-up. With trench isolation, this diode is removed, and the result is a latch-up proof switch.

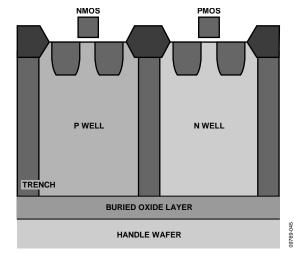
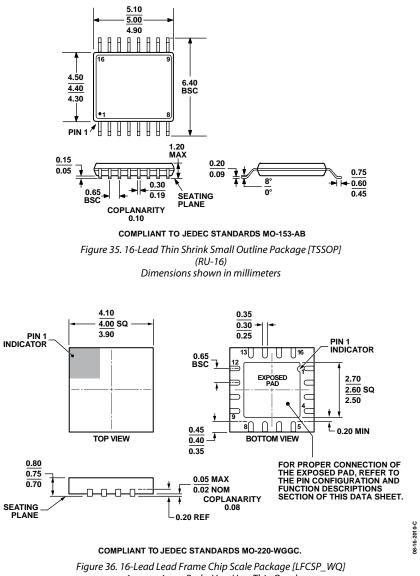


Figure 34. Trench Isolation

### **APPLICATIONS INFORMATION**

The ADG52xx family of switches and multiplexers provide a robust solution for instrumentation, industrial, automotive, aerospace, and other harsh environments that are prone to latch-up, which is an undesirable high current state that can lead to device failure and persists until the power supply is turned off. The ADG5236 high voltage switches allow single-supply operation from 9 V to 40 V and dual supply operation from  $\pm 9$  V to  $\pm 22$  V.

### **OUTLINE DIMENSIONS**



igure 36. 16-Lead Lead Frame Chip Scale Package [LFCSP\_WQ] 4 mm × 4 mm Body, Very Very Thin Quad (CP-16-17) Dimensions shown in millimeters

#### **ORDERING GUIDE**

Model <sup>1</sup>	Temperature Range	Package Description	Package Option
ADG5236BRUZ	-40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG5236BRUZ-RL7	-40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG5236BCPZ-RL7	-40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCSP_WQ]	CP-16-17

 $^{1}$  Z = RoHS Compliant Part.

## **Data Sheet**

### NOTES



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